



**AUDIX TECHNOLOGY CORPORATION**

**EMC DEPARTMENT**

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# Technical Compliance Statement

**No. EM-E160546**

The following products has been tested by us with the listed standards and found in compliance with the council EMC directive 2014/30/EU. It is possible to use CE marking to demonstrate the compliance with this EMC Directive.

**Submittor : FSP Group Inc.**  
**No. 22, Jianguo E. Rd., Taoyuan City, Taiwan**

**Product : Switching Power Supply**  
**M/N (1)FSP550-80ETN (2)SPI550ACAP (3)EA-550 PLATINUM**  
**(4)FSP600-80ETN (5)SPI600ACAP (6)PT-600**  
**(7)FSP650-80ETN (8)SPI650ACAP (9)EA-650 PLATINUM**  
**(10)FSP700-80ETN (11)SPI700ACAP (12)PT-700**  
**(13)EA-750 PLATINUM (14)FSP750-80ETN**  
**Brand (1)(4)(6)(7)(10)(12)(14)FSP (2)(5)(8)(11)SPI (3)(9)(13)Antec**

Test Standards	
<b>EN 61204-3:2000</b>	Low voltage power supplies, d.c. output Part 3: Electromagnetic compatibility (EMC)
<b>EN 55022:2010 +AC:2011</b>	Limits and methods of measurement of radio disturbance characteristics of information technology equipment
<b>AS/NZS CISPR 22:2009 +A1:2010</b>	
<b>EN 61000-3-2:2014</b>	Part 3 : Limits-Section 2 : Limits for harmonic current emission (equipment input current <=16A per phase)
<b>EN 61000-3-3:2013</b>	Part 3 : Limits-Section 3 : Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current <=16A
<b>EN 55024:2010 +A1:2015</b>	Information technology equipment-Immunity characteristics Limits and methods of measurement
	<b>IEC 61000-4-2:2008</b> Electrostatic discharge immunity test
	<b>IEC 61000-4-3:2010</b> Radiated, radio-frequency electromagnetic field immunity test
	<b>IEC 61000-4-4:2012</b> Electrical fast transient / burst immunity test
	<b>IEC 61000-4-5:2014</b> Surge immunity test
	<b>IEC 61000-4-6:2013</b> Immunity to conducted disturbances, induced by radio-frequency fields
	<b>IEC 61000-4-8:2009</b> Power Frequency Magnetic field immunity test
	<b>IEC 61000-4-11:2004</b> Voltage dips, short interruptions and voltage variations immunity test



*Alex Deng*  
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Alex Deng/Deputy Manager

The verification is based on a single evaluation of one sample of above mentioned products. It does not imply an assessment of the whole production and does not permit the use of the test lab. logo.